

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCX00FT, TC74VCX00FK

Low-Voltage Quad 2-Input NAND Gate with 3.6-V Tolerant Inputs and Outputs

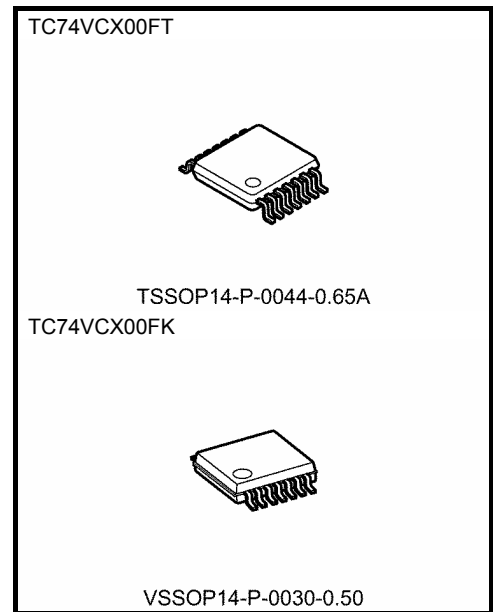
The TC74VCX00FT/FK is a high-performance CMOS 2-input NAND gate which is guaranteed to operate from 1.2-V to 3.6-V. Designed for use in 1.5V, 1.8V, 2.5V or 3.3V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to 3.6 V.

All inputs are equipped with protection circuits against static discharge.

Features (Note)

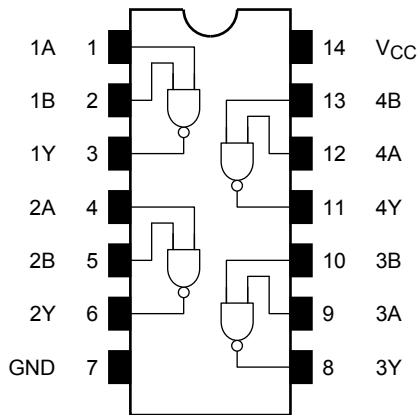
- Low-voltage operation: $V_{CC} = 1.2\sim 3.6\text{ V}$
- High-speed operation: $t_{pd} = 2.8\text{ ns (max) (}V_{CC} = 3.0\sim 3.6\text{ V)}$
 : $t_{pd} = 3.7\text{ ns (max) (}V_{CC} = 2.3\sim 2.7\text{ V)}$
 : $t_{pd} = 7.4\text{ ns (max) (}V_{CC} = 1.65\sim 1.95\text{ V)}$
 : $t_{pd} = 14.8\text{ ns (max) (}V_{CC} = 1.4\sim 1.6\text{ V)}$
 : $t_{pd} = 37.0\text{ ns (max) (}V_{CC} = 1.2\text{ V)}$
- Output current: $I_{OH}/I_{OL} = \pm 24\text{ mA (min) (}V_{CC} = 3.0\text{ V)}$
 : $I_{OH}/I_{OL} = \pm 18\text{ mA (min) (}V_{CC} = 2.3\text{ V)}$
 : $I_{OH}/I_{OL} = \pm 6\text{ mA (min) (}V_{CC} = 1.65\text{ V)}$
 : $I_{OH}/I_{OL} = \pm 2\text{ mA (min) (}V_{CC} = 1.4\text{ V)}$
- Latch-up performance: $\pm 300\text{ mA}$
- ESD performance: Machine model $> \pm 200\text{ V}$
 : Human body model $> \pm 2000\text{ V}$
- Package: TSSOP (thin shrink small outline package)
- Power-down protection provided on all inputs and outputs



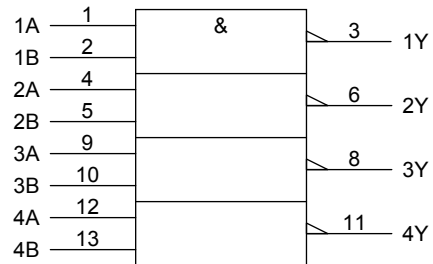
Weight	
TSSOP14-P-0044-0.65A	: 0.06 g (typ.)
VSSOP14-P-0030-0.50	: 0.02 g (typ.)

Note: Electrical Characteristics of $V_{CC}=1.5\pm 0.1\text{ V}$ and 1.2 V apply only to products whose Lot Code is over "3 12" .

Pin Assignment (top view)



IEC Logic Symbol



Truth Table

Inputs		Outputs
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	-0.5~4.6	V
DC input voltage	V_{IN}	-0.5~4.6	V
DC output voltage	V_{OUT}	-0.5~4.6 (Note 2)	V
		-0.5~ $V_{CC} + 0.5$ (Note 3)	
Input diode current	I_{IK}	-50	mA
Output diode current	I_{OK}	±50 (Note 4)	mA
DC output current	I_{OUT}	±50	mA
Power dissipation	P_D	180	mW
DC V_{CC} /ground current	I_{CC}/I_{GND}	±100	mA
Storage temperature	T_{stg}	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Note 2: $V_{CC} = 0$ V

Note 3: High or low state. I_{OUT} absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND$, $V_{OUT} > V_{CC}$

Recommended Operating Range (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	1.2~3.6	V
Input voltage	V_{IN}	-0.3~3.6	V
Output voltage	V_{OUT}	0~3.6 (Note 2)	V
		0~ V_{CC} (Note 3)	
Output current	I_{OH}/I_{OL}	± 24 (Note 4)	mA
		± 18 (Note 5)	
		± 6 (Note 6)	
		± 2 (Note 7)	
Operating temperature	T_{opr}	-40~85	°C
Input rise and fall time	dt/dv	0~10 (Note 8)	ns/V

Note 1: The recommended operating conditions are required to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.

Note 2: $V_{CC} = 0$ V

Note 3: High or low state

Note 4: $V_{CC} = 3.0\sim 3.6$ V

Note 5: $V_{CC} = 2.3\sim 2.7$ V

Note 6: $V_{CC} = 1.65\sim 1.95$ V

Note 7: $V_{CC} = 1.4\sim 1.6$ V

Note 8: $V_{IN} = 0.8\sim 2.0$ V, $V_{CC} = 3.0$ V

Electrical Characteristics

DC Characteristics ($T_a = -40$ to 85°C , 2.7 V $< V_{CC} \leq 3.6$ V)

Characteristics		Symbol	Test Condition	V_{CC} (V)	Min	Max	Unit
Input voltage	H-level	V_{IH}	—	2.7~3.6	2.0	—	V
	L-level	V_{IL}	—	2.7~3.6	—	0.8	
Output voltage	H-level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu\text{A}$	2.7~3.6	$V_{CC} - 0.2$	V
				$I_{OH} = -12 \text{ mA}$	2.7	2.2	
				$I_{OH} = -18 \text{ mA}$	3.0	2.4	
				$I_{OH} = -24 \text{ mA}$	3.0	2.2	
	L-level	V_{OL}	$V_{IN} = V_{IH}$	$I_{OL} = 100 \mu\text{A}$	2.7~3.6	—	0.2
				$I_{OL} = 12 \text{ mA}$	2.7	—	0.4
				$I_{OL} = 18 \text{ mA}$	3.0	—	0.4
				$I_{OL} = 24 \text{ mA}$	3.0	—	0.55
Input leakage current		I_{IN}	$V_{IN} = 0$ to 3.6 V	2.7~3.6	—	± 5.0	μA
Power-off leakage current		I_{OFF}	$V_{IN}, V_{OUT} = 0$ to 3.6 V	0	—	10.0	μA
Quiescent supply current		I_{CC}	$V_{IN} = V_{CC}$ or GND	2.7~3.6	—	20.0	μA
			$V_{CC} \leq V_{IN} \leq 3.6$ V	2.7~3.6	—	± 20.0	
Increase in I_{CC} per input		ΔI_{CC}	$V_{IH} = V_{CC} - 0.6$ V	2.7~3.6	—	750	

DC Characteristics (Ta = -40 to 85°C, 2.3 V ≤ VCC ≤ 2.7 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		2.3~2.7	1.6	—	V
	L-level	V _{IL}	—		2.3~2.7	—	0.7	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	2.3~2.7	V _{CC} - 0.2	—	V
				I _{OH} = -6 mA	2.3	2.0	—	
				I _{OH} = -12 mA	2.3	1.8	—	
	L-level	V _{OL}	V _{IN} = V _{IH}	I _{OL} = 100 μA	2.3~2.7	—	0.2	
				I _{OL} = 12 mA	2.3	—	0.4	
				I _{OL} = 18 mA	2.3	—	0.6	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		2.3~2.7	—	±5.0	μA
Power-off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		2.3~2.7	—	20.0	μA
			V _{CC} ≤ V _{IN} ≤ 3.6 V		2.3~2.7	—	±20.0	

DC Characteristics (Ta = -40 to 85°C, 1.65 V ≤ VCC < 2.3 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		1.65~2.3	0.65 × V _{CC}	—	V
	L-level	V _{IL}	—		1.65~2.3	—	0.2 × V _{CC}	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.65	V _{CC} - 0.2	—	V
				I _{OH} = -6 mA	1.65	1.25	—	
	L-level	V _{OL}	V _{IN} = V _{IH}	I _{OL} = 100 μA	1.65	—	0.2	
				I _{OL} = 6 mA	1.65	—	0.3	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		1.65~2.3	—	±5.0	μA
Power-off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		1.65~2.3	—	20.0	μA
			V _{CC} ≤ V _{IN} ≤ 3.6 V		1.65~2.3	—	±20.0	

DC Characteristics (Ta = -40 to 85°C, 1.4 V ≤ VCC < 1.65 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		1.4~1.65	0.65 × V _{CC}	—	V
	L-level	V _{IL}	—		1.4~1.65	—	0.05 × V _{CC}	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.4~1.65	V _{CC} - 0.2	—	V
				I _{OH} = -2 mA	1.4	1.05	—	
	L-level	V _{OL}	V _{IN} = V _{IH}	I _{OL} = 100 μA	1.4~1.65	—	0.05	
				I _{OL} = 2 mA	1.4	—	0.35	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		1.4~1.65	—	±5.0	μA
Power-off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		1.4~1.65	—	20.0	μA
			V _{CC} ≤ V _{IN} ≤ 3.6 V		1.4~1.65	—	±20.0	

DC Characteristics (Ta = -40 to 85°C, 1.2 V ≤ VCC < 1.4 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		1.2~1.4	0.8 × V _{CC}	—	V
	L-level	V _{IL}	—		1.2~1.4	—	0.05 × V _{CC}	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.2	V _{CC} - 0.1	—	V
	L-level	V _{OL}	V _{IN} = V _{IH}	I _{OL} = 100 μA	1.2	—	0.05	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		1.2	—	±5.0	μA
Power-off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		1.2	—	20.0	μA
			V _{CC} ≤ V _{IN} ≤ 3.6 V		1.2	—	±20.0	

AC Characteristics (Ta = -40 to 85°C, input: tr = tf = 2.0 ns) (Note 1)

Characteristics	Symbol	Test Condition	VCC (V)	Min	Max	Unit	
Propagation delay time	t _{pLH} t _{pHL}	Figure 1, Figure 2	C _L = 15 pF, R _L = 2 kΩ	1.2	1.5	37.0	ns
				1.5 ± 0.1	1.0	14.8	
	C _L = 30 pF, R _L = 500 Ω	1.8 ± 0.15	1.5	7.4			
		2.5 ± 0.2	0.8	3.7			
Output to output skew	t _{osLH} t _{osHL}	(Note 2)	C _L = 15 pF, R _L = 2 kΩ	1.2	—	1.5	ns
				1.5 ± 0.1	—	1.5	
	C _L = 30 pF, R _L = 500 Ω	1.8 ± 0.15	—	0.5			
		2.5 ± 0.2	—	0.5			
			3.3 ± 0.3	—	0.5		

Note 1: For C_L = 50 pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

$$(t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|)$$

Dynamic Switching Characteristics (Ta = 25°C, input: tr = tf = 2.0 ns, C_L = 30 pF)

Characteristics	Symbol	Test Condition	VCC (V)	Typ.	Unit
Quiet output maximum dynamic V _{OL}	V _{OLP}	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	0.25	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	0.8	
Quiet output minimum dynamic V _{OL}	V _{OLV}	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	-0.25	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	-0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	-0.8	
Quiet output minimum dynamic V _{OH}	V _{OHV}	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	1.5	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	1.9	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	2.2	

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	VCC (V)	Typ.	Unit
Input capacitance	C _{IN}	—	1.8, 2.5, 3.3	6	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz (Note)	1.8, 2.5, 3.3	20	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC(opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/4 \text{ (per gate)}$$

AC Test Circuit

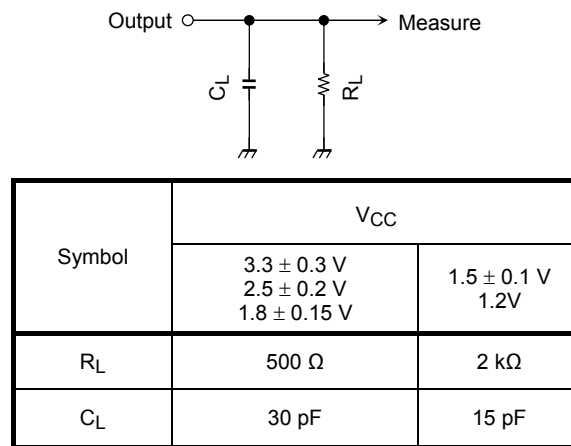
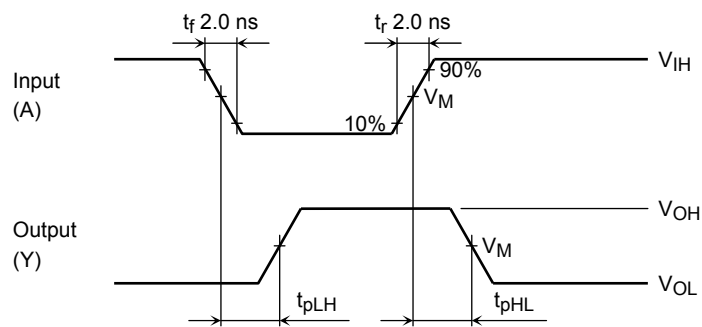


Figure 1

AC Waveform



Symbol	V _{CC}				
		3.3 ± 0.3 V	2.5 ± 0.2 V	1.8 ± 0.15 V	1.5 ± 0.1 V
V _{IH}	2.7 V	V _{CC}	V _{CC}	V _{CC}	V _{CC}
V _M	1.5 V	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2

Figure 2 t_{pLH}, t_{pHL}

Package Dimensions

TSSOP14-P-0044-0.65A

Unit: mm

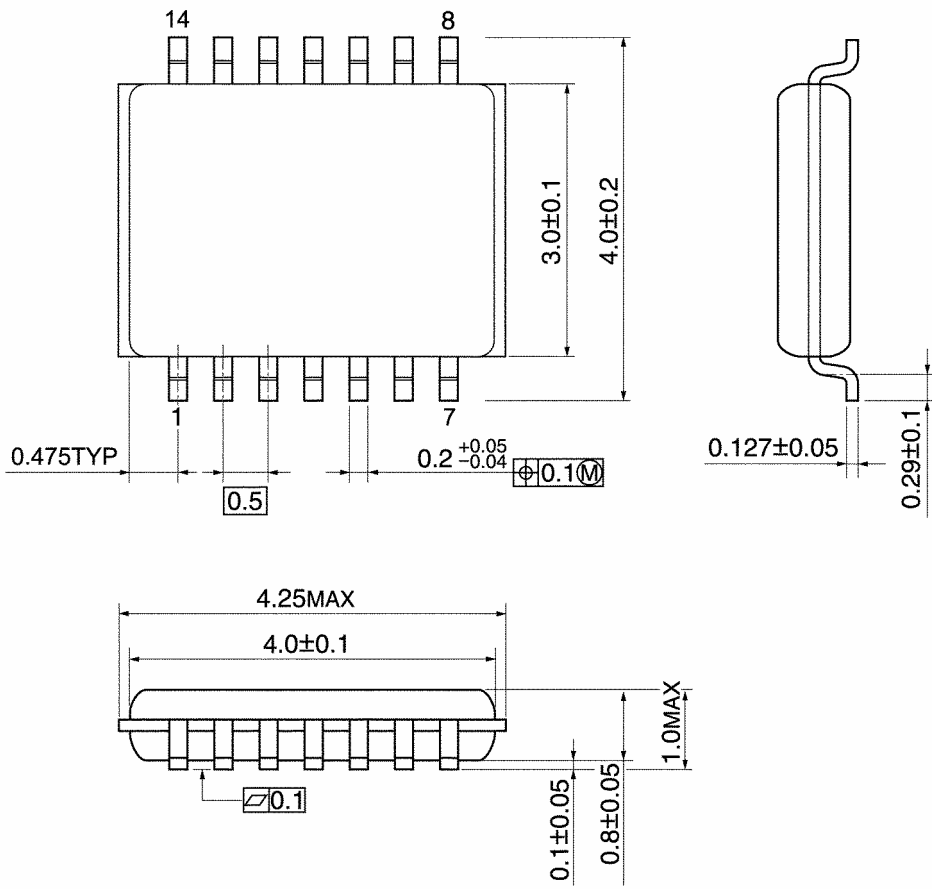


Weight: 0.06 g (typ.)

Package Dimensions

VSSOP14-P-0030-0.50

Unit: mm



Weight: 0.02 g (typ.)

Note: Lead (Pb)-Free Packages**TSSOP14-P-0044-0.65A VSSOP14-P-0030-0.50****RESTRICTIONS ON PRODUCT USE**

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS compatibility. Please use these products in this document in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring as a result of noncompliance with applicable laws and regulations.